## Application/Control No. Applicant(s)/Patent Under Reexamination 10/736,922 WEI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1753 Kishor Mayekar **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,368,668 B1 04-2002 Kobayashi et al. 427/376.2 Α US-6,627,173 B2 09-2003 Hemme et al. 423/598 В Reisfeld et al. С US-2003/0021720 A1 01-2003 422/4 D US-2003/0050196 A1 03-2003 Hirano et al. 507/238 Ε US-F US-US-G US-Н US-J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.